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Docket No.: SAA-002

PATENT

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of

Inventor(s): Nobukatsu NISHIDA et al.

Confirmation No. 1793

U.S. Patent Application No. 10/533,581

Group Art Unit: 2632

Filed: May 3, 2005

Examiner: n/a

For:

METHOD, SYSTEM, AND APPARATUS FOR DETACHING AND COLLECTING AN IC

TAG FROM A PAPER SHEET TO WHICH IT IS ATTACHED

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Sir:

In accordance with the provisions of 37 C.F.R. 1.56, 1.97 and 1.98, the attention of the Patent and Trademark Office is hereby directed to the documents listed on the attached form PTO-1449. It is respectfully requested that the documents be expressly considered during the prosecution of this application, and that the documents be made of record therein and appear among the "References Cited" on any patent to issue therefrom.

This Information Disclosure Statement is being filed within three months of the U.S. filing date OR before the mailing date of a first Office Action on the merits. No certification or fee is required.

Respectfully submitted,

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KMB/iyr

INFORMATION DISCLOSTIES CITATION IN AN (%)				ATTY. DOCKET NO. SAA-002		U.S. PATENT APPLICATION NO. 10/533,581			
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EXAMINER	1		I	OATE CONSIDERE	D				

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.